

Notice of References Cited

Application/Control No.

10/577,857

Applicant(s)/Patent Under
Reexamination
KSONTINI ET AL.

Examiner

MICHAEL R. VAUGHAN

Art Unit

2431

Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2001/0051515 A1	12-2001	Rygaard, Christopher A.	455/410
*	B	US-6,341,373 B1	01-2002	Shaw, Robert	717/173
*	C	US-2004/0015694 A1	01-2004	DeTreville, John	713/172
*	D	US-6,714,778 B2	03-2004	Nykanen et al.	455/414.1
*	E	US-2004/0102987 A1	05-2004	Takahashi et al.	705/001
*	F	US-6,775,536 B1	08-2004	Geiger et al.	455/411
*	G	US-2004/0199787 A1	10-2004	Hans et al.	713/200
*	H	US-6,832,230 B1	12-2004	Ziliacus et al.	707/203
*	I	US-2005/0097053 A1	05-2005	Aaltonen et al.	705/051
*	J	US-7,139,915 B2	11-2006	DeTreville, John D.	713/172
*	K	US-2006/0288407 A1	12-2006	Naslund et al.	726/009
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)				
	U					
	V					
	W					
	X					

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
 Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.